<Full SiC Power Modules>

## FMF1200DXZ-24B

## HIGH POWER SWITCHING USE

INSULATED TYPE

| Dual switch (Half-Bridge) | Drain current ID $\qquad$ 1200 A <br> Drain-Source voltage VDsx $\qquad$ 1200 V <br> Maximum junction temperature $\mathrm{T}_{\mathrm{vjmax}}$................... $175^{\circ} \mathrm{C}$ <br> -Silicon Carbide MOSFET + Silicon Carbide Schottky Barrier Diode <br> -Flat base Type <br> - Copper base plate <br> -RoHS Directive compliant <br> -Recognized under UL1557, File E323585 |
| :---: | :---: |

## APPLICATION

AC Motor Control, Power supply, etc.

<Full SiC Power Modules>

## FMF1200DXZ-24B

high power switching use
INSULATED TYPE
MAXIMUM RATINGS ( $\mathrm{T}_{\mathrm{vj}}=25^{\circ} \mathrm{C}$, unless otherwise specified)

| Symbol | Item | Conditions | Rating | Unit |
| :---: | :---: | :---: | :---: | :---: |
| $V_{\text {DSX }}$ | Drain-source voltage | $\mathrm{V}_{\mathrm{GS}}=-15 \mathrm{~V}$ | 1200 | V |
| $\mathrm{V}_{\text {GSS }}$ | Gate-source voltage | D-S short-circuited | $\pm 20$ | V |
| $\mathrm{I}_{\mathrm{D}}$ | Drain current | $\mathrm{DC}, \mathrm{T}_{\mathrm{c}}=61^{\circ} \mathrm{C}{ }^{\text {(Note.2) }}$ | 1200 | A |
| $\mathrm{I}_{\text {DRM }}$ |  | Pulse, Repetitive ${ }^{(\text {Note.3) }}, \mathrm{T}_{\mathrm{vj}}=150^{\circ} \mathrm{C}^{\text {(Note.4) }}$ | 1800 |  |
| $\mathrm{P}_{\text {tot }}$ | Total power dissipation | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ (Note. 2) | 4540 | W |
| Is $\quad$ (Note.1) | Source current | DC | 1200 | A |
| ISRM (Note.1) |  | Pulse, Repetitive ${ }^{(\text {Note.3) }, ~} \mathrm{T}_{\mathrm{vj}}=150{ }^{\circ} \mathrm{C}$ | 1800 |  |
| $\mathrm{V}_{\text {isol }}$ | Isolation voltage | Terminals to base plate, RMS, f=60 Hz, AC 1 min | 5000 | V |
| $\mathrm{T}_{\mathrm{vj} \text { max }}$ | Maximum junction temperature | Instantaneous event (overload) ${ }^{\text {(Note.10) }}$ | 175 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {vjop }}$ | Operating junction temperature | Continuous operation (under switching) ${ }^{(\text {Note.10) }}$ | $-40 \sim+150$ | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {cmax }}$ | Maximum case temperature | (Note.2, 10) | 125 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {stg }}$ | Storage temperature | - | $-40 \sim+125$ | ${ }^{\circ} \mathrm{C}$ |

ELECTRICAL CHARACTERISTICS ( $\mathrm{T}_{\mathrm{vj}}=25^{\circ} \mathrm{C}$, unless otherwise specified)

| Symbol | Item | Conditions ${ }^{\text {(note9) }}$ |  |  | Limits |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Min. | Typ. | Max. |  |
| $\operatorname{ldsx}$ | Drain-source cut-off current | $\mathrm{V}_{\text {DS }}=\mathrm{V}_{\text {DSX }}, \mathrm{V}_{\text {GS }}=-15 \mathrm{~V}$ |  | - | - | 12.5 | mA |
|  |  | $\mathrm{V}_{\text {DS }}=800 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=-15 \mathrm{~V}$ |  | - | - | 1.25 |  |
| $\mathrm{V}_{\mathrm{GS} \text { (th) }}$ | Gate-source threshold voltage | $\mathrm{I}_{\mathrm{D}}=360 \mathrm{~mA}, \mathrm{~V}_{\mathrm{DS}}=10 \mathrm{~V}$ |  | 1.8 | 2.5 | 3.2 | V |
| $\mathrm{I}_{\text {GSS }}$ | Gate-source leakage current | $\mathrm{V}_{\mathrm{GS}}=\mathrm{V}_{\text {GSS }}$, $\mathrm{D}-\mathrm{S}$ short-circuited |  | - | - | 0.5 | $\mu \mathrm{A}$ |
| $V_{D S(o n)}$ (terminal) | Drain-source on-state voltage | $\mathrm{I}_{\mathrm{D}}=1200 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=15 \mathrm{~V}$ (Note.6) | $\mathrm{T}_{\mathrm{vj}}=25^{\circ} \mathrm{C}$ | - | 1.60 | 2.36 | V |
|  |  |  | $\mathrm{T}_{\mathrm{vj}}=125^{\circ} \mathrm{C}$ | - | 2.03 | - |  |
|  |  |  | $\mathrm{T}_{\mathrm{vj}}=150^{\circ} \mathrm{C}$ | - | 2.12 | - |  |
| $V_{\text {DS(on) }}$ (chip) | Drain-source on-state voltage | $\mathrm{I}_{\mathrm{D}}=1200 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=15 \mathrm{~V}$ (Note.6) | $\mathrm{T}_{\mathrm{vj}}=25^{\circ} \mathrm{C}$ | - | 1.30 | - | V |
|  |  |  | $\mathrm{T}_{\mathrm{vj}}=125^{\circ} \mathrm{C}$ | - | 1.73 | - |  |
|  |  |  | $\mathrm{T}_{\mathrm{vj}}=150^{\circ} \mathrm{C}$ | - | 1.82 | - |  |
| $r_{\mathrm{DS}(o n)}$(chip) | Drain-source on-state resistance | $\mathrm{I}_{\mathrm{D}}=1200 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=15 \mathrm{~V}$ (Note.6) | $\mathrm{T}_{\mathrm{vj}}=25^{\circ} \mathrm{C}$ | - | 1.1 | - | $\mathrm{m} \Omega$ |
|  |  |  | $\mathrm{T}_{\mathrm{vj}}=125^{\circ} \mathrm{C}$ | - | 1.4 | - |  |
|  |  |  | $\mathrm{T}_{\mathrm{vj}}=150^{\circ} \mathrm{C}$ | - | 1.5 | - |  |
| $\mathrm{C}_{\text {is }}$ | Input capacitance | $\mathrm{V}_{\mathrm{DS}}=10 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  | - | 89.2 | - | nF |
| $\mathrm{C}_{\text {oss }}$ | Output capacitance |  |  | - | 64.7 | - |  |
| $\mathrm{C}_{\text {rss }}$ | Reverse transfer capacitance |  |  | - | 5.3 | - |  |
| $\mathrm{Q}_{\text {G }}$ | Gate charge | $\mathrm{V}_{\mathrm{DD}}=600 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=1200 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \rightarrow 15 \mathrm{~V}$ |  | - | 2570 | - | nC |
| $\mathrm{t}_{\mathrm{d} \text { (on) }}$ | Turn-on delay time | $V_{D D}=600 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=1200 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}= \pm 15 \mathrm{~V}, \mathrm{~T}_{\mathrm{Vj}}=150^{\circ} \mathrm{C}$, $R_{G}=1.0 \Omega, L_{s_{-} e x=}=16 n H$, Inductive load, per pulse |  | - | 350 | - | ns |
| $\mathrm{t}_{\mathrm{r}}$ | Rise time |  |  | - | 120 | - |  |
| $\mathrm{t}_{\mathrm{d} \text { ( off) }}$ | Turn-off delay time |  |  | - | 440 | - |  |
| $\mathrm{t}_{\mathrm{f}}$ | Fall time |  |  | - | 80 | - |  |
| $\mathrm{E}_{\text {on }}$ | Turn-on switching energy |  |  | - | 66 | - | I |
| $E_{\text {off }}$ | Turn-off switching energy |  |  | - | 54 | - | J |
| $\mathrm{Q}_{\text {c }}$ | Drain-source charge |  |  | - | 6.3 | - | $\mu \mathrm{C}$ |
| $\begin{array}{\|l} \hline \mathrm{V}_{\text {SD }} \\ \text { (terminal) } \end{array}$ | Source-drain voltage | $\begin{aligned} & \mathrm{I}_{\mathrm{s}}=1200 \mathrm{~A}^{\text {(Notet. } 6)} \\ & \mathrm{V}_{\mathrm{GS}}=-15 \mathrm{~V} \end{aligned}$ | $\mathrm{T}_{\mathrm{vj}}=25^{\circ} \mathrm{C}$ | - | 1.87 | 2.40 | V |
|  |  |  | $\mathrm{T}_{\mathrm{vj}}=125^{\circ} \mathrm{C}$ | - | 2.63 | - |  |
|  |  |  | $\mathrm{T}_{\mathrm{vj}}=150^{\circ} \mathrm{C}$ | - | 2.82 | - |  |
| $\begin{array}{\|l} \left\lvert\, \begin{array}{l} \text { V } \\ \text { (chip) } \end{array}\right. \\ \text { (Note. 1) } \end{array}$ | Source-drain voltage | $\begin{aligned} & \left.I_{s}=1200 \mathrm{~A} \text { (Note. } 6\right) \\ & \mathrm{V}_{\mathrm{GS}}=-15 \mathrm{~V} \end{aligned}$ | $\mathrm{T}_{\mathrm{vj}}=25^{\circ} \mathrm{C}$ | - | 1.57 | - | V |
|  |  |  | $\mathrm{T}_{\mathrm{vj}}=125^{\circ} \mathrm{C}$ | - | 2.33 | - |  |
|  |  |  | $\mathrm{T}_{\mathrm{vj}}=150^{\circ} \mathrm{C}$ | - | 2.52 | - |  |
| $\mathrm{R}_{\mathrm{DD} \text { '+SS }}$ | Internal lead resistance | P-EP, OUT-EN terminals, per switch |  | - | 0.25 | - | $\mathrm{m} \Omega$ |
| $\mathrm{L}_{\text {s }}$ | Internal stray inductance | P-N |  | - | 15 | - | nH |
| $\mathrm{r}_{\mathrm{g} \text { (on) }}$ | Internal gate resistance (on) | Per switch |  | - | 0.65 | - | $\Omega$ |
| $r_{\text {g(off) }}$ | Internal gate resistance (off) | Per switch |  | - | 3.07 | - | $\Omega$ |

HIGH POWER SWITCHING USE
INSULATED TYPE
THERMAL RESISTANCE CHARACTERISTICS

| Symbol | Item | Conditions | Limits |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min. | Typ. | Max. |  |
| $\mathrm{R}_{\mathrm{th}(\mathrm{j}-\mathrm{c}) \mathrm{Q}}$ | Thermal resistance ${ }^{(\text {Note. 2) }}$ | Junction to case, per inverter switch | - | - | 33 | K/kW |
| $\mathrm{R}_{\mathrm{th}(\mathrm{j}-\mathrm{c}) \mathrm{D}}$ |  | Junction to case, per inverter FWD | - | - | 47 |  |
| $\mathrm{R}_{\mathrm{th}(\mathrm{c}-\mathrm{s})}$ | Contact thermal resistance ${ }^{(\text {Note.2) }}$ | Case to heat sink, per 1 module, Thermal grease applied (Note.8, 10) | - | 6 | - | K/kW |

## NTC THERMISTOR PART

| Symbol | Item | Conditions | Limits |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min. | Typ. | Max. |  |
| $\mathrm{R}_{25}$ | Zero-power resistance | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ ( (Note.2) | 4.85 | 5.00 | 5.15 | k $\Omega$ |
| $\Delta \mathrm{R} / \mathrm{R}$ | Deviation of resistance | $\mathrm{T}_{\mathrm{C}}=100{ }^{\circ} \mathrm{C}{ }^{\text {(Note. })^{2}}, \mathrm{R}_{100}=493 \Omega$ | -7.3 | - | +7.8 | \% |
| $\mathrm{B}_{(25 / 50)}$ | B-constant | Approximate by equation (Note.7) | - | 3375 | - | K |
| $\mathrm{P}_{25}$ | Power dissipation | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ ( (Note. 2 ) | - | - | 10 | mW |

MECHANICAL CHARACTERISTICS

| Symbol | Item | Conditions |  | Limits |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Min. | Typ. | Max. |  |
| $\mathrm{M}_{\mathrm{t}}$ | Mounting torque | Main terminals | M 6 screw | 3.5 | 4.0 | 4.5 | $\mathrm{N} \cdot \mathrm{m}$ |
| $\mathrm{M}_{\text {s }}$ |  | Mounting to heat sink | M 5 screw | 2.5 | 3.0 | 3.5 |  |
| m | mass | - |  | - | 920 | - | g |
| $\mathrm{d}_{\mathrm{a}}$ | Clearance |  |  | 10.0 | - | - | mm |
| $\mathrm{d}_{\text {s }}$ | Creepage distance |  |  | 17.5 | - | - | mm |
| $\mathrm{e}_{\mathrm{c}}$ | Flatness of base plate | On the centerline $\mathrm{X}, \mathrm{Y}$ (Note.5) |  | -100 | - | +120 | $\mu \mathrm{m}$ |
| - | Connector insertion force | 2 pin type |  | 0 | - | 25 | N |
|  |  | 4 pin type |  | 0 | - | 35 | N |

*: This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU and (EU)2015/863.
Note1. Represent ratings and characteristics of the anti-parallel, source-drain free wheeling diode (FWD).
2. Case temperature ( $\mathrm{T}_{\mathrm{c}}$ ) and heat sink temperature $\left(\mathrm{T}_{\mathrm{s}}\right)$ are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.
3. Pulse width and repetition rate should be such that the device junction temperature ( $\mathrm{T}_{\mathrm{vj}}$ ) does not exceed $\mathrm{T}_{\mathrm{vjmax}}$ rating.
4. Junction temperature ( $\mathrm{T}_{\mathrm{vj}}$ ) should not increase beyond $\mathrm{T}_{\mathrm{vj} \mathrm{max}}$ rating.
5. The base plate (mounting side) flatness measurement points ( $\mathrm{X}, \mathrm{Y}$ ) are as follows of the following figure.

6. Pulse width and repetition rate should be such as to cause negligible temperature rise.
7. $\mathrm{B}_{(25 / 50)}=\ln \left(\frac{\mathrm{R}_{25}}{\mathrm{R}_{50}}\right) /\left(\frac{1}{\mathrm{~T}_{25}}-\frac{1}{\mathrm{~T}_{50}}\right)$
$\mathrm{R}_{25}$ : resistance at absolute temperature $\mathrm{T}_{25}[\mathrm{~K}] ; \mathrm{T}_{25}=25\left[{ }^{\circ} \mathrm{C}\right]+273.15=298.15[\mathrm{~K}]$
$\mathrm{R}_{50}$ : resistance at absolute temperature $\mathrm{T}_{50}[\mathrm{~K}] ; \mathrm{T}_{50}=50\left[{ }^{\circ} \mathrm{C}\right]+273.15=323.15[\mathrm{~K}]$
8. Reference value. Thermally conductive grease of $\lambda=0.9 \mathrm{~W} /(\mathrm{m} \cdot \mathrm{K})$ and thickness $\mathrm{D}_{(\mathrm{c}-\mathrm{s})}=100 \mu \mathrm{~m}$.
9. Per switch (ex. Tr1 chips total in page.6)
10. Long term performance related to thermal conductive grease (including but not limited to aspects such as the increase of thermal resistance due to pumping out, etc.) should be verified under your specific application conditions. Each temperature condition ( $T_{v j \max }, T_{v j \text { op }}, T_{c}$ max ) must be maintained below the maximum rated temperature throughout consideration of the temperature rise even for long term usage.

## RECOMMENDED OPERATING CONDITIONS

| Symbol | Item | Conditions | Limits |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min. | Typ. | Max. |  |
| $V_{D D}$ | (DC) Supply voltage | Applied across aP -aN, bP-bN terminals | - | 600 | 850 | V |
| $V_{D}$ | DC supply voltage (control) | Applied across VDP-EP, VDN-EN terminals | 13.5 | 15.0 | 16.5 | V |
| $\mathrm{V}_{\mathrm{GS}(+)}$ | Gate-Source positive drive voltage | Applied across GP-EP, GN-EN terminals | 13.5 | 15.0 | 16.5 | V |
| $\mathrm{V}_{\text {GS(-) }}$ | Gate-Source negative drive voltage | Applied across GP-EP, GN-EN terminals | -16.5 | -15.0 | -7.0 | V |
| $\mathrm{R}_{\mathrm{G}}$ | External gate resistance ${ }^{\text {(Note.11) }}$ | Per switch | 1.0 | - | 5.0 | $\Omega$ |
| $\mathrm{f}_{\mathrm{c}}$ | Switching frequency | $\mathrm{V}_{G S}= \pm 15 \mathrm{~V}, \mathrm{R}_{\mathrm{G}}=1.0 \Omega, \mathrm{~V}_{\mathrm{DD}}=600 \mathrm{~V}, \mathrm{~T}_{\mathrm{vj}}=150^{\circ} \mathrm{C}$ | - | - | 50 | kHz |
| $\mathrm{t}_{\text {d(SCoff) }}$ | Gate cutoff delay time after SC output | $\mathrm{V}_{G S}=15 \mathrm{~V}, \mathrm{R}_{\mathrm{G}}=1.0 \Omega, \mathrm{~V}_{\mathrm{DD}} \leqq 850 \mathrm{~V}, \mathrm{~T}_{\mathrm{vj}}=150^{\circ} \mathrm{C}$ | - | - | 3 | $\mu \mathrm{s}$ |

Note 11. The value of external gate resistance should be considered the surge voltage not to exceed the rating voltage in the worst system condition.

## SHORT CIRCUIT DETECTION \& PROTECTION CHARACTERISTICS

| Symbol | Item | Conditions | Limits |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min. | Typ. | Max. |  |
| $\mathrm{I}_{\mathrm{D}(\mathrm{SC})}$ | SC detect drain current | $\mathrm{T}_{\mathrm{j} j}=150^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{GS}}=15 \mathrm{~V}$ | 1800 | 2400 | - | A |
| $\mathrm{t}_{\mathrm{d}(\mathrm{SC})}$ | SC detect delay time | $\mathrm{T}_{\mathrm{Vj}}=150^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{GS}}=15 \mathrm{~V}, \mathrm{R}_{\mathrm{G}}=1.0 \Omega$ | - | 1 | - | $\mu \mathrm{s}$ |
| $\mathrm{V}_{\mathrm{GS}(\mathrm{SC})}$ | SC protection gate limit voltage | $\mathrm{T}_{\mathrm{Vj}}=150^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{Gs}}=15 \mathrm{~V}, \mathrm{R}_{\mathrm{G}}=1.0 \Omega$ | - | 5.8 | - | V |
| R1 | SC protection gate limit resistance | - | - | 0.50 | - | $\Omega$ |

Refer to the circuit in page. 5

## SHORT CIRCUIT DETECTION \& PROTECTION




Tr1,Tr2: SiC-MOSFET, Di1,Di2: SiC-SBD, Th: NTC thermistor

TEST CIRCUIT AND WAVEFORMS


Switching characteristics test circuit and waveforms(x: connected a* and b*)


Qc test waveform


MOSFET Turn-on switching energy


MOSFET Turn-off switching energy

Turn-on / Turn-off switching energy test waveforms (Integral time instruction drawing)

## TEST CIRCUIT



VSD test circuit, $\mathrm{V}_{G S}=-15 \mathrm{~V}$ ( x : Connected $\mathrm{a}^{*}$ and $\mathrm{b}^{*}$ )

$V_{S D}$ test circuit, $\mathrm{V}_{\mathrm{GS}}=15 \mathrm{~V}$ (x: Connected $\mathrm{a}^{*}$ and $\mathrm{b}^{*}$ )

PERFORMANCE CURVES
OUTPUT
CHARACTERISTICS
(TYPICAL)


DRAIN-SOURCE ON STATE VOLTAGE CHARACTERISTICS (TYPICAL)


DRAIN-SOURCE ON STATE VOLTAGE CHARACTERISTICS (TYPICAL)


## PERFORMANCE CURVES

FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)


> CAPACITANCE CHARACTERISTICS (TYPICAL)


SOURCE-DRAIN ON STATE VOLTAGE CHARACTERISTICS (TYPICAL)


> GATE CHARGE CHARACTERISTICS (TYPICAL)


## PERFORMANCE CURVES

HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)


HALF-BRIDGE
SWITCHING CHARACTERISTICS (TYPICAL)
$V_{D D}=600 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}= \pm 15 \mathrm{~V}, \mathrm{R}_{\mathrm{G}}=1.0 \Omega, \mathrm{~T}_{\mathrm{vj}}=150^{\circ} \mathrm{C}, \mathrm{L}_{\mathrm{s} \_ \text {ext }}=16 \mathrm{nH}$ INDUCTIVE LOAD, PER PULSE


HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

$V_{D D}=600 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}= \pm 15 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=1200 \mathrm{~A}, \mathrm{~T}_{\mathrm{vj}}=150^{\circ} \mathrm{C}, \mathrm{L}_{\mathrm{s} \_ \text {ext }}=16 \mathrm{nH}$ INDUCTIVE LOAD, PER PULSE



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

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